

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Marc Arques et al.

Serial No.:

10/716,779

Filing Date:

November 19, 2003

Title:

"PARTICLE DETECTOR AND ASSOCIATED

PARTICLE DETECTION METHOD"

Docket No.:

36278

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, Va. 22313-1450

Sir/Madam:

In accordance with Rule 56, applicants are aware of the publications listed in the French Search Report (copy enclosed) and in the enclosed copy of Patent Office Form 1449. A copy of each of the publications is enclosed herewith.

Respectfully submitted, PEARNE & GORDON LLP

By:_

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December 11, 2003

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner of Patents, P.O. Box 1450, Alexandria, Va. 22313-1450 on the date indicated below.

Jeffrey J. Sopko

Name of Attorney for Applicant(s)

12/11/2003

Date

Signature of Attorney

OIPE 15 2003 55 Form 1888-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 36278

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INFORMATION DISCLOSURE CITATION BY APPLICANT

(USE SEVERAL SHEETS IF NECESSARY)

APPLICANT: Marc Arques et al.

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Examiner Initial		Document No.	Date	Name	e		Clas	ss	Subc	lass	Filing Date If Appropriate	
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